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#### INFORMATION DISCLOSURE STATEMENT BY APPLICANT

of

Complete if Known								
Application Number	10/796,207							
Filing Date	03/10/2004							
First Named Inventor	Kato, et al.							
Art Unit	1753							
Examiner Name	TBD							
Attorney Docket Number	520,30414C55							

	U.S. PATENT DOCUMENTS											
Examiner Initials'	Cite No. <sup>1</sup>	Document Number  Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear							
WE		US- 5,536,128	7/16/1996	Shimoyashiro, et al.								
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		FOREIG	N PATENT DOC	UMENTS		
Examiner Initials'	Cite No. <sup>1</sup>	Foreign Patent Document  Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>6</sup> (if known)  JP 64-036042	Publication Date MM-DD-YYYY 2/7/1989	Name of Patentee or Applicant of Cited Document Kokusai Electric Co., Ltd.	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T°

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
KSO	*	S. Nakagawa, "Dry Etching", Drafts in Symposium of VLSI and FA Technology, April 1985, pages 1-14	
K20)		N. Nagai, "Parallel-Implantation lon Implantation Device "NH-20SP", Special Issue/Semiconductor Manufacturing Device of Half-Micron Age, pages 1-12, 3/1990	
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{		Semiconductor Equipment Association of Japan, "Semiconductor News", Vol. 4, pp. 38-43, April 10, 1987 (w/ translation).													
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<sup>\*</sup> PTR (partial translation) - FTR (full translation) - ABS (abstract)

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OTHER DOCUMENTS \* (Including Author, Title, Date, Pertinent Pages Fig.)

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N <sub>2</sub>	L	Terminological Dictionary of Semiconductor Equipment, Edited by Semiconductor Equipment Association of Japan, Published by Nikkan Kogyo Shinbun sha Inc. (1987) p. 183 (PTR)
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1.	AZ	"Semiconductor World", 1990/9, Published by Press Journal, Inc., pp. 136-7 (FTR)
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<sup>\*</sup> PTR (partial translation) - FTR (full translation) - ABS (abstract)

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